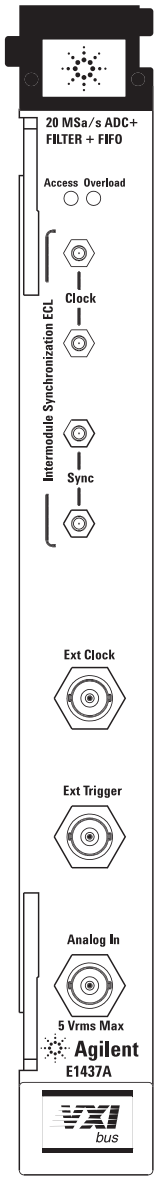
Agilent E1437A

20 MSample/Second ADC with Filter and FIFO

Technical Specifications



Agilent E1437A

Whether you analyze spectra or capture waveforms, the Agilent E1437A ADC will help you see signal features you may have never seen before.

A Remarkable Digitizer

At the heart of the E1437A is an exceptionally low distortion digitizer. Low distortion means high quality data will reveal even more about your signal when averaged, filtered or FFT processed.

Analog Signal Conditioning

You aren't restricted to operating the E1437A at a specific amplitude operating point thanks to built-in analog signal conditioning.

Digital Filtering and LO

Use the 24 real-time digital filters built-in to the E1437A to increase the precision of the output samples, or filter out extraneous signals.

FIFO Memory

The FIFO means you won't lose new samples while you are transferring a data block out.

VXI*plug&play* Programming

The E1437A is VXI*plug&play* compatible and is shipped with software and documentation to support a broad set of controllers, and operating systems.

High Speed Data Transfers

VXI Local Bus capability means the E1437A can output data at 40 MB/s continuously and as high as 60 MB/s when transferring blocks of data.

Agilent Technologies

Specifications

Input

Input Modes

DC coupled, AC coupled.
Input grounded, input connected.
Input BNC shell grounded, floating.

Full Scale Input Ranges

(ADC clipping levels, dBm values are approximate)

Volts peak	dBm, 50 Ω
10.24 V	30
5.12 V	24
2.56 V	18
1.28 V	12
640 mV	6
320 mV	0
160 mV	-6
80 mV	-12
40 mV	-18
20 mV	-24

Maximum Input Level
(for any time interval > 10 ms)

10 Vrms for 5.12 V and 10.24 V ranges,
5 Vrms for all other ranges

Return loss of 50 W Input Impedance
(±1%, DC coupled, BNC shell grounded, frequency < 8 MHz)

> 40 dB

AC Coupling Characterisitics
(A 0.2 µF capacitor is placed in series with the input signal)

0.2 µF (typical)
Maximum DC voltage is ±50 V

Common Mode Characteristics

Shell floating impedance	50 Ω in parallel with 0.04 µF (typical)
Shell grounded impedance	< 0.1 (typical)
Maximum Current (diode clamped to < ±1 V peak)	±1 amp peak

Common Mode Response
(Response to a sine wave voltage source of amplitude Vcom (in mV) applied through a 50 Ω series resistor; frequency < 8 MHz.)

Range	Response in dBfs
30 dBm to 0 dBm	< (-90 + 20 x LOG(Vcom))
-6 dBm	< (-80 + 20 x LOG(Vcom))
-12 dBm to -24 dBm	< (-65 + 20 x LOG(Vcom))

Accuracy

Resolution	Raw ADC resolution		23 bits, two's complement
	After digital zoom and filter operations		32 bits, full resolution mode 16 bits, reduced resolution mode
Amplitude Accuracy: (< 100 kHz, 25°C, analog alias filter on, digital decimation filters off, DC coupled)			
	Absolute voltage measurement accuracy 12 dBm range		±0.03 dB
	Range accuracy relative to 12 dBm range		±0.03 dB (for all ranges)
	Alias filter off relative to alias filter on mode at 12 kHz		±0.02 dB
	Temperature drift		< 0.001 dB/°C (typical) of deviation from 25°C
DC offset	Temperature drift		
		30 dBm to -6 dBm ranges	< ±0.01%/°C (typical)
		-12 to -24 dBm ranges	< ±0.1 mV/°C (typical)
	Input bias current (in parallel with 50 Ω input load)		< 64 µA
Flatness (dB peak-to-peak, excluding digital filter response)			
	Alias filter on		
		freq < 100 kHz	< 0.03 dBpp
		freq < 5 MHz	< 0.25 dBpp
		freq < 8 MHz	< 0.80 dBpp
	Alias filter off		
		freq < 8 MHz	< 0.25 dBpp
		freq < 40 MHz	3 dBpp (typical)
Anti-alias filter stopband rejection (12 MHz to 20 MHz)	> 100 dB		

Dynamic Range

NOTE: The performance specifications for the spurious response and discrete sidebands characteristics require that the mainframe containing the E1437A have the optional connector shields installed. They are not required for MFRAME1. In addition all modules in the mainframe must comply with the VXI 1.4 specification for ECL trigger lines; and the 10-MHz VXI system clock must be turned off. External clock input must be disconnected when not being used for ADC clock.

Signal to Noise Ratio (The reference signal is a sine wave with peaks at the clipping voltage of the current range; typical values)

Alias filter on		
	-6 dBm to 30 dBm ranges	71 dB
	-12 dBm range	70 dB
	-18 dBm range	68 dB
	-24 dBm range	65 dB
Alias filter off		
	-6 dBm to 30 dBm ranges	68 dB
	-12 dBm range	66 dB
	-18 dBm range	61 dB
	-24 dBm range	57 dB

Input Noise Density (Alias filter on, Internal sample clock)

	dBfs/Hz	**dBm/Hz**
-6 dBm to 30 dBm ranges		
1 MHz to 8 MHz	-140 dBfs/Hz	
100 kHz to 1 MHz	-138 dBfs/Hz	
10 kHz to 100 kHz	-135 dBfs/Hz	
1 kHz to 10 kHz	-131 dBfs/Hz	
100 Hz	-120 dBfs/Hz	
-12 dBm range		
1 MHz to 8 MHz	-139 dBfs/Hz	-151 dBm/Hz
100 kHz to 1 MHz	-137 dBfs/Hz	-149 dBm/Hz
10 kHz to 100 kHz	-134 dBfs/Hz	-146 dBm/Hz
1 kHz to 10 kHz	-129 dBfs/Hz	-141 dBm/Hz
100 Hz	-118 dBfs/Hz	-130 dBm/Hz
-18 dBm range		
1 MHz to 8 MHz	-137 dBfs/Hz	-155 dBm/Hz
100 kHz to 1 MHz	-135 dBfs/Hz	-153 dBm/Hz
10 kHz to 100 kHz	-131 dBfs/Hz	-149 dBm/Hz
1 kHz to 10 kHz	-125 dBfs/Hz	-143 dBm/Hz
100 Hz	-114 dBfs/Hz	-132 dBm/Hz
-24 dBm range		
1 MHz to 8 MHz	-134 dBfs/Hz	-158 dBm/Hz
100 kHz to 1 MHz	-132 dBfs/Hz	-156 dBm/Hz
10 kHz to 100 kHz	-127 dBfs/Hz	-151 dBm/Hz
1 kHz to 10 kHz	-120 dBfs/Hz	-144 dBm/Hz
100 Hz	-108 dBfs/Hz	-132 dBm/Hz

Spurious Response
(2 kHz to 8 MHz, terminated with 50 Ω, input BNC shell grounded)

DSP clock = ADC clock, alias filter on	< -110 dBfs
DSP clock ≠ ADC clock, alias filter on	< -95 dBfs
DSP clock = ADC clock, alias filter off	< -70 dBfs

Phase Noise

Phase noise density
(Single sideband power density of a 5 MHz signal, vibration < 0.05 G)

	20 MHz clock	20.48 MHz clock
Δf = 100 kHz	< -138 dBc/Hz	< -138 dBc/Hz
Δf = 1 kHz	< -130 dBc/Hz	< -130 dBc/Hz
Δf = 100 Hz	< -105 dBc/Hz	< -120 dBc/Hz

Discrete sidebands
(100 Hz < Δf < 1 MHz, other modules must comply with VXI 1.4 specification for ECL trigger lines, External Clock disconnected)

Internal clock	< -100 dBc
Internal clock (distributed on backplane with CLK10 backplane clock disabled)	< -80 dBc (typical)

Distortion

Harmonic distortion products to 8 MHz
(Includes aliased distortion components)

for inputs < -6 dBfs	< -75 dBc or < -110 dBfs
for inputs > -6 dBfs	< -70 dBc or < -110 dBfs

Intermodulation distortion products to 8 MHz
(Includes aliased distortion components)

for inputs < -9 dBfs	< -75 dBc or < -110 dBfs
for inputs > -9 dBfs	< -70 dBc or < -110 dBfs

Clock

Clock Input/Output Characteristics

External ADC clock input (AC coupled with small-signal input impedance of 100 kΩ above 10 kHz. Large signals are diode clamped through 100 Ω)	TTL, ECL, or >-6 dBm sine waves, BNC input
Intermodule Synchronization Clock/SYNC	ECL-10 K compatible, SMB

Clock Source Frequencies

Internal ADC clock		20 MHz or 20.48 MHz
External sample clock frequency range		
	DSP clock = ADC clock	2 MHz to 20.60 MHz
	DSP clock ≠ ADC clock	0 Hz to 20 MHz
DSP clock		
	Internal	20 MHz or 20.48 MHz
	ADC	ADC clock must be > 2 MHz in this mode

Internal Clock Characteristics

Frequency Accuracy (20 MHz or 20.48 MHz, 0°C to 40°C)	±100 Hz
Jitter	< 5 ps rms (typical) (see phase noise specification for spectral content of jitter)

Sampling Skew (typical)

Within mainframe (rear clock distribution)	< 10 ns (typical)
Between mainframes (clock extended via a 1 m coaxial cable)	< 25 ns (typical)

Trigger

Trigger sources	External TTL/ECL/sine wave, level, LOG(magnitude), software (via register write)	
Slope	Positive/negative	
Threshold		
	Level trigger	V_{range} x N/128, -128 ≤ N ≤ 128; hysteresis is $\frac{V_{range}}{256}$
	LOG (magnitude) trigger	V_{range} (dBm) - N x 0.3762574 dBm, 0 ≤ N ≤ 255; hysteresis is 1.5 dB
External trigger input	BNC Connector, AC-coupled comparator with 1 kΩ	
	TTL/ECL/SINE wave	
	Sine wave frequency	> 50 kHz
	Detects pulses	> 100 ns with edges > 100 mV
Trigger offset		
	Resolution (in output sample periods)	1 sample, 32-bit complex data 2 samples, 16-bit complex or 32-bit real data 4 samples, 16-bit real data
	Maximum pre-trigger delay	(132 - $\frac{\text{dram size}}{8}$) x trigger offset resolution
	Maximum post-trigger delay	16,777,116 x trigger offset resolution

$$H(f) = H_{analog}(f) \bullet H_{digital}\left(N \frac{f - f_0}{f_s}\right)$$

where:
f = input signal frequency
f_0 = zoom center frequency (zero in baseband mode)
f_s = ADC sampling frequency
N = Digital filter bandwidth selector; N = 0, 1, 2, 3, ..., 24

Analog Frequency Response Function
(typical), with alias filter off.

$$H_{analog} = \prod_{n=1}^{5} \frac{1}{1 - jf / B_n}$$

n	Poles, Bn (MHz)
1	-80.234 + j 0.0
2	-103.94 + j 0.0
3	-103.94 - j 0.0
4	-72.9774 + j 49.94437
5	-72.9774 - j 49.94437

Analog Frequency Response Function
(typical), with alias filter on.

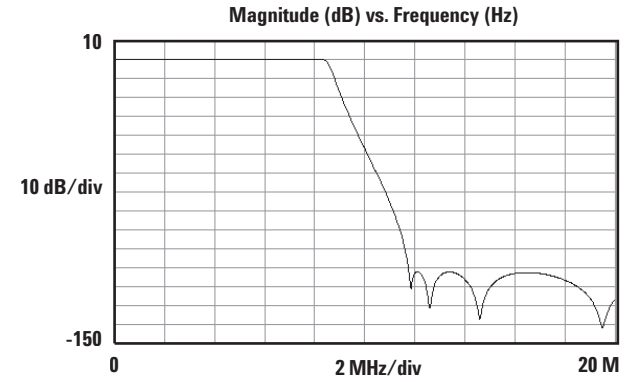
$$H_{analog} = \prod_{n=1}^{11} \frac{1 - jf / A_n}{1 - jf / B_n}$$

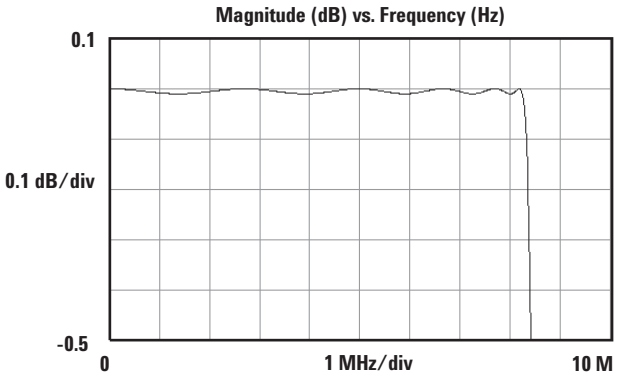
n	Zeros, An (MHz)	Poles, Bn (MHz)
1	∞	-3.423881 + j 0.0
2	-0.278765 + j 37.0	-3.122370 + j 3.010688
3	-0.278765 - j 37.0	-3.122370 - j 3.010688
4	-0.085700 + j 19.5	-2.397607 + j 5.453639
5	-0.085700 - j 19.5	-2.397607 - j 5.453639
6	-0.053075 + j 14.6	-1.579759 + j 7.117287
7	-0.053075 - j 14.6	-1.579759 - j 7.117287
8	-0.042453 + j 12.6	-0.864515 + j 8.088296
9	-0.042453 - j 12.6	-0.864515 - j 8.088296
10	-0.038826 + j 11.84	-0.271817 + j 8.524792
11	-0.038826 - j 11.84	-0.271817 - j 8.524792

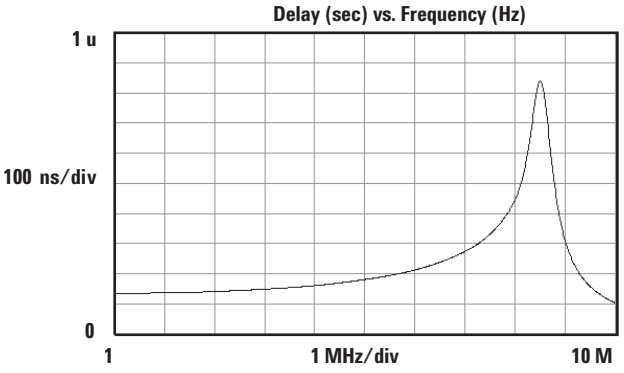
Digital Frequency Response Function

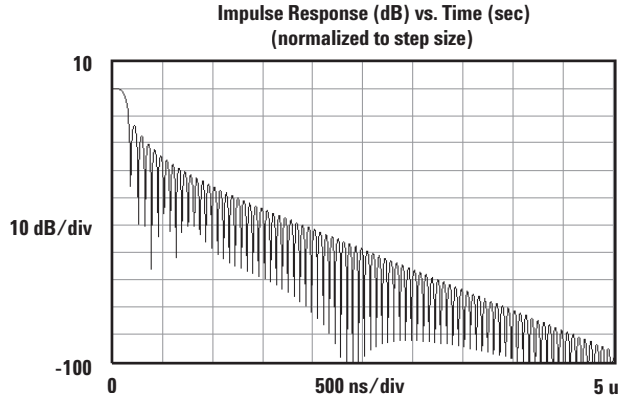
$$H_{digital}\left(N \frac{f - f_o}{f_s}\right) = \begin{cases} 1, N = 0 \\ \prod_{n=1}^{N} \left(\frac{z^3 + 2z^2 + 3z + 1}{4z^3 + 2z} \right)^5 \Big|_{z = e^{jz^n p(f - f_o)/f_s}}, N > 0 \end{cases}$$

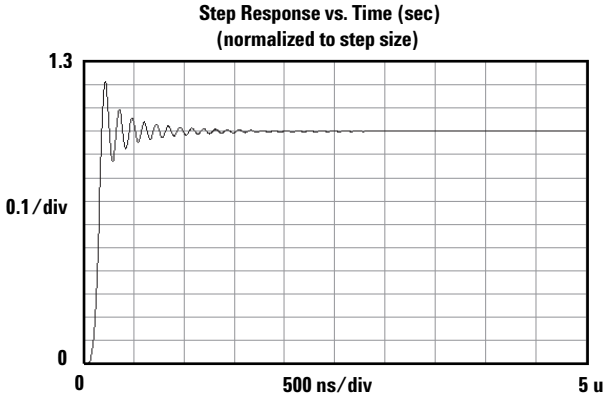
Filter characteristics for nominal analog alias filter, N = 0



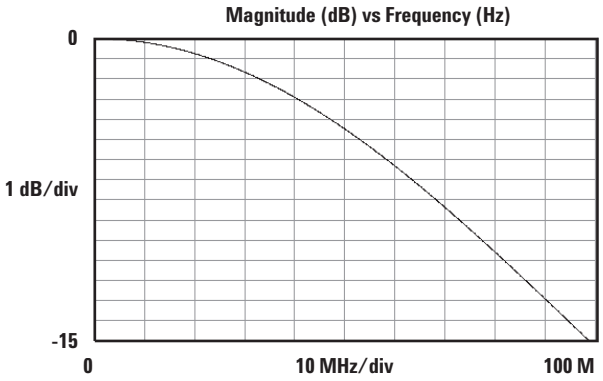


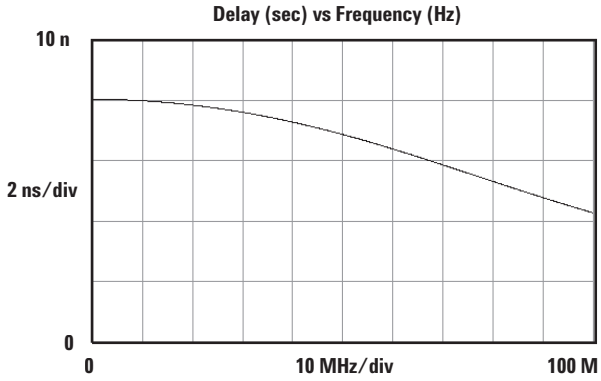


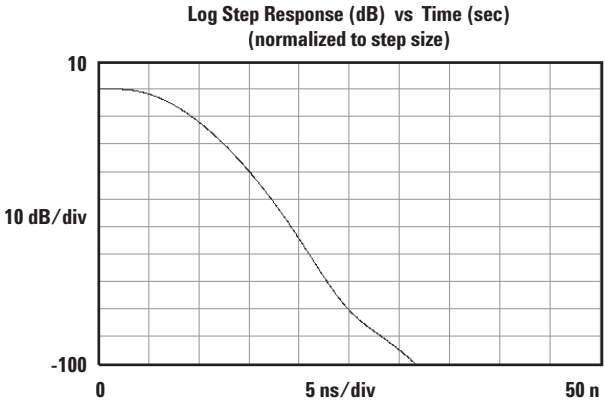


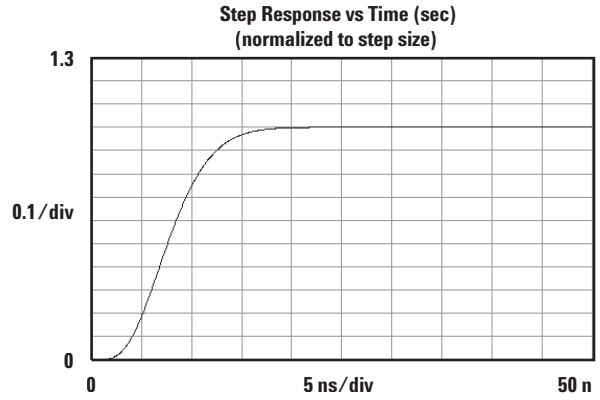


Filter characteristics with all alias filtering turned off, N = 1

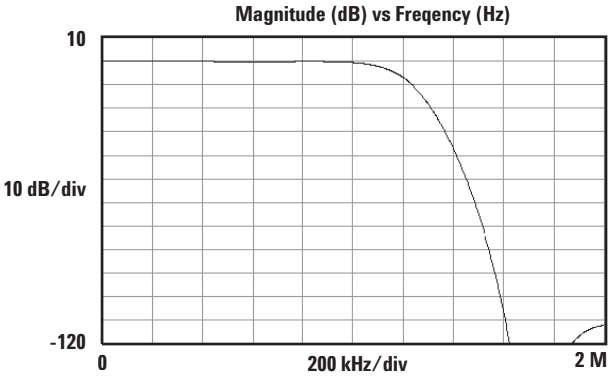


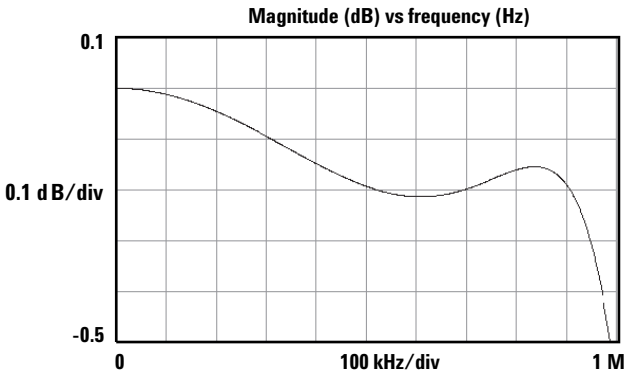


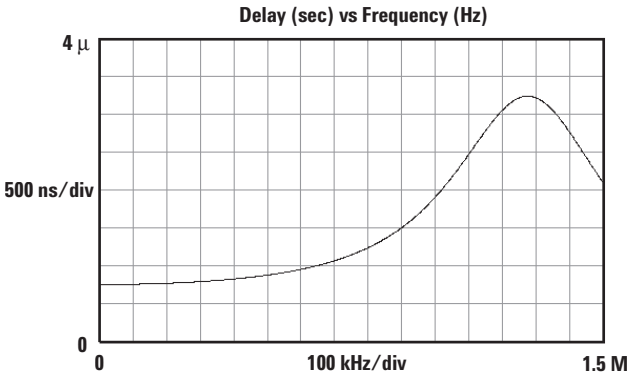


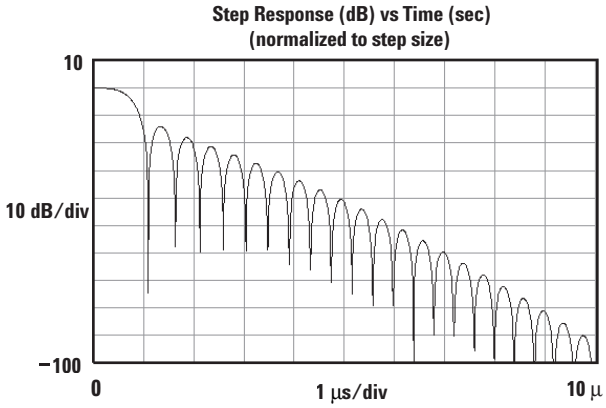


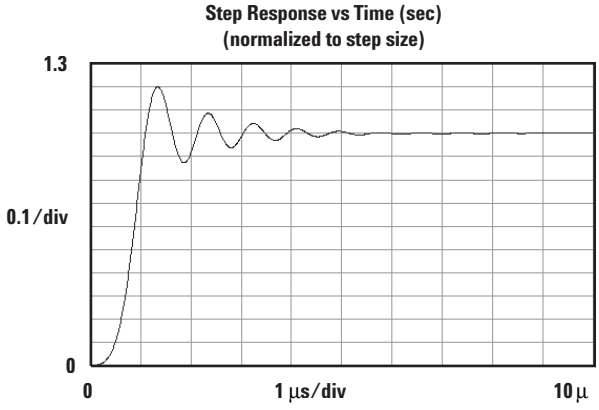
Filter characteristics for 3rd pass digital filter + analog filter (dominated by digital), N = 3











Programming

(all functions are programmable
via the VXI register interface)

Center frequency		
	Resolution	ADC clock frequency ÷ (1024 x 10^9)
	Range	±ADC clock frequency ÷ 2
Filtering and decimation		
	Bandwidths (-15 dB) (See the frequency response section for filter characteristics)	±0.5 x Fs/2^N, 0 ≤ N ≤ 24
	Output sample rate	Fs/2^N (nyquist sampled) 2 x Fs/2^N (2X over-sampled)
Data output		
	Type	real, complex
	Resolution	16 bits, 32 bits
	Output ports	VME data transfers Local Bus data transfers
	Transfer rate	60 MByte/s, burst 40 MByte/s, sustained 2 MByte/s, VME
	Block sizes	8, 16, 32, ..., up to memory size bytes
Measurement modes		Block mode (individually triggered blocks) Continuous mode
Information available in read registers		
	Manufacturer's code	4095 decimal (Agilent Technologies)
	Model code	534 decimal (E1437A)
	Other Status bits	Measurement loop status, Ready, ADC error, Ext clk error, Set-up error, Sync/Idle complete, Read Valid, Measure done, Armed, FIFO overflow, Overload, Error, Mod ID, Hardware set.
Interrupts		Two independent priority interrupts initiated by masked status bits
Memory		
	Type	FIFO
	Capacity	8 MBytes (4 MSamples, 16 bits) 16 MBytes (8 MSamples,16 bits) option UFC 32 MBytes (16 MSamples, 16 bits) option ANC 64 MBytes (32 MSamples, 16 bits) option ANE

VXI System Level Specifications

VXI Standard Information			
	Conforms to VXI Rev. 1.4		
	C-size, single slot width		
	Register/Message based programming		
	"Slave" Data Transfer Bus functionality		
	A16 address capability		
	D16 data capability		
	Local Bus capability		
	Requires ECLTRG0 and ECLTRG1 lines for module synchronization		
Size (single slot, C-size VXI module)	Dimensions	14 inches deep, 9.2 inches high, 1.2 inches wide (approx 36 cm deep, 23 cm high, 3 cm wide)	
	Weight	3.9 pounds (approx 1.8 kg)	

Software Drivers

Driver Type	C libraries with source code
Supported Operating Systems	MS Windows® 3.1, Windows 95, Windows NT, Windows 2000®, HP-UX* 9.X, and HP-UX 10.2
Supply Media	Disk, DAT

Regulatory Compliance

Safety Standards	Designed for compliance to CSA C22.2, No. 231
	Designed for compliance to UL 1244, 4th Edition
	Designed for compliance to IEC 348, 2nd Edition, 1978
Radiated Emissions	CISPR 11 :1990 Group 1, Class A (requires connector shields E1400-80920 in the mainframe)

Environmental

Operating Restrictions	Ambient Temperature	0° to 55°C
	Humidity, Non-condensing	10% to 90% at 40°C
	Maximum Altitude	4600 m (15,000 ft) Above 2285 m (7500 ft), derate operating temperature by -3.6°C per 1000 m (-1.1°C per 1000 ft)
Storage and Transport Restrictions	Ambient Temperature	40° to 70°C
	Humidity, Non-condensing	max 95% RH at 65°C
	Maximum Altitude	4600 m (15,000 ft)

* HP-UX 9.X and 10.0 for HP 9000 Series 700 and 800 computers are X/Open Company UNIX 93 branded products.

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General Characteristics

VXI Power Requirements

Range	DC Current	Dynamic Current
+5 V	5.0 A	0.50 A
-5.2 V	5.0 A	0.50 A
-2 V	0.3 A	0.10 A
+12 V	1.0 A	0.050 A
-12 V	1.2 A	0.050 A
+24 V	0.0 A	0.0 A
-24 V	0.0 A	0.0 A

VXI Cooling Requirements 15°C rise	4.0 liters/second 0.5 mm H_2O
Calibration interval	1 year
Warm-up time	15 minutes

Ordering Information

E1437A	20 MSa/s AD with filter and FIFO
E1437A-UFC	16 MB FIFO memory
E1437A-ANC	32 MB FIFO memory
E1437A-ANE	64 MB FIFO memory
E1437A-0B0	Delete manual set
E1437A-0B1	Add manual set

Specification Note

Specifications describe warranted performance over the temperature range of 0° to 55°C, after a 15-minute warm-up from ambient conditions and automatic calibrations enabled unless otherwise noted. Supplemental characteristics identified as "typical" or "characteristic," provide useful information by giving non-warranted performance parameters. Typical performance is applicable from 20° to 30°C.

Abbreviations

dBm = dB relative to 1 mW into 50 Ω

dBfs = dB relative to full scale amplitude range.

dBc = dB relative to carrier amplitude.

Typical = typical, non-warranted, performance specification included to provide general product information.

Related Agilent Literature

E1437A 20 MSample/Second ADC with Filter and FIFO Product Overview
literature number 5965-6893E

E1438A/B 100 MSample/Second Digitizer with DSP and Memory Product Overview
literature number 5968-7348E

E1438A/B 100 MSample/Second Digitizer with DSP and Memory Technical Specifications
literature number 5968-8233E

E1439A/B VXI 70 MHz IF ADC with Filters and Memory Product Overview
literature number 5980-1261E

E1439A/B VXI 70 MHz IF ADC with Filters and Memory Technical Specifications
literature number 5980-1260E

E9830A Delay Memory Module Product Overview
literature number 5968-7349E

Agilent Test Systems and VXI Products Catalog
literature number 5980-0307E

Warranty

This product is distributed warranted, and supported by Agilent Technologies.

The E1430A comes with a 1-year warranty. During that period, the unit will either be replace or repaired, Agilent Technologies' option, and returned to the customer without charge.

Visit our Websites

Agilent Communications Intelligence Information — **www.agilent.com/find/AD**

Agilent VXI Product Information — **www.agilent.com/find/vxi**

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